

| L Number | Hits | Search Text | DB | Time stamp |
|----------|-------|---|---|---------------------|
| 1 | 4732 | (250/306,307,311,442.11).CCLS. | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:45 |
| 2 | 7 | (((((imag\$4 with (sample or wafer or specimen or semiconductor)) and (stor\$4 near4 (data or information) with (area or region))) and (control\$4 with position\$3 with (sample or wafer or substrate or semiconductor))) and (locat\$4 near2 defect\$4)) and (scale or scaling)) and ((250/306,307,311,442.11).CCLS.) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:47 |
| 3 | 36765 | inspect\$5 near4 (sample or wafer or semiconductor or substrate or defect or anomaly) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:51 |
| 4 | 11 | "6292582" and (scale or scaling) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:54 |
| 5 | 615 | (referenc\$4 near1 image) and (inspect\$4 near4 defect) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:55 |
| 6 | 157 | ((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 15:57 |
| 7 | 18 | ((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3)) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:08 |
| 8 | 10 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3))) and (locat\$5 near3 defect) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:12 |
| 9 | 5 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3))) and (locat\$5 near3 defect)) and (magnif\$5 with imag\$4 with defect) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:12 |
| 10 | 5 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3))) and (locat\$5 near3 defect)) and (magnif\$5 with imag\$4 with defect)) and display\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:13 |
| 12 | 20 | ((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and ((scale or reduc\$4 or magnif\$5) near1 (value or factor\$3)) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:09 |
| 13 | 1 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and ((scale or reduc\$4 or magnif\$5) near1 (value or factor\$3))) and ((scale or reduc\$4 or magnif\$5) near1 second) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:10 |

| | | | | |
|----|----|--|---|---------------------|
| 14 | 0 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and ((scale or reduc\$4 or magnif\$5) near1 (value or factor\$3))) and ((scale or reduc\$4 or magnif\$5) near1 second)) and (locat\$5 near3 defect) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:11 |
| 11 | 18 | ((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3 or coefficient)) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:12 |
| 15 | 10 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3 or coefficient))) and (locat\$5 near3 defect) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:12 |
| 16 | 8 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3 or coefficient))) and (locat\$5 near3 defect)) and (magnif\$5 with imag\$4) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:13 |
| 17 | 8 | (((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3 or coefficient))) and (locat\$5 near3 defect)) and (magnif\$5 with imag\$4)) and display\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:34 |
| 18 | 0 | ((((((referenc\$4 near1 image) and (inspect\$4 near4 defect)) and ((position\$3 or mov\$4) with view\$3)) and (scale near1 (value or factor\$3 or coefficient))) and (locat\$5 near3 defect)) and (magnif\$5 with imag\$4)) and display\$4) and ((250/306,307,311,442.11).CCLS.) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2003/07/17 16:34 |